

Editorial

As we enter 2008, I'd like to note that ACM TODAES is continuing efforts to ensure that accepted manuscripts appear in the next available issue, thereby eliminating the publication backlog for accepted manuscripts. The pace of submissions to TODAES has accelerated and we are continuing to receive very high quality submissions.

In 2008 we are also featuring some exciting special sections and issues. This issue features a special section focused on the topics of high-level design, validation, and testing. The April 2008 issue will feature a joint section with ACM JETC with papers that address the topic of design automation for emerging nanotechnologies. And later in 2008, we expect to have another special issue on "Demonstrable Software Systems and Hardware Platforms" that will highlight working CAD systems and artifacts that not only have outstanding technical content, but which have also been demonstrated as working systems at forums such as the annual SIGDA/DAC University Booth.

2008 will also mark a transition in our editorial board. I plan to step down as Editor-in-Chief (EiC) later this year, and several new Associate Editors will be appointed. The ACM Editorial Board will appoint a selection committee that will issue a call for EiC nominations; please take the time to respond by sending in names for this solicitation.

In closing, I wish all of our readers a very happy, safe, and productive new year!

NIKIL DUTT
Editor-in-Chief